

<b>Notice of References Cited</b>	Application/Control No. 10/552,046		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner KAREN M. KUSUMAKAR		Art Unit 2829	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0210433	09-2007	Subraya et al.	257/686
*	B	US-7,199,453	04-2007	Lai et al.	257/666
*	C	US-6,987,058	01-2006	Hall, Frank L.	438/617
*	D	US-7,005,316	02-2006	Lee et al.	438/106
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.